

CMOS linear image sensor



S10226-10

Small, resin-sealed CMOS image sensor

The S10226-10 is a resin-sealed CMOS linear image sensor to offer compact size and high cost-performance compared to our previous product (S9226 series).

Features

- Compact and high cost-performance
 Surface mount type package: 2.4 × 9.1 × 1.6^t mm
- Pixel pitch: 7.8 μm
 Pixel height: 125 μm
- **1024 pixels**
- **■** Single 3.3 V power supply operation
- High sensitivity, low dark current, low noise
- On-chip charge amplifier with excellent input/output characteristics
- Built-in timing generator allows operation with only Start and Clock pulse inputs.
- **▶** Video data rate: 200 kHz max.
- Spectral response range: 400 to 1000 nm

Applications

- **■** Barcode readers
- Displacement meters
- Refractometers
- **■** Interferometers
- **■** Miniature spectrometers

Structure

Parameter	Specification	Unit
Number of pixels	1024	-
Pixel pitch	7.8	μm
Pixel height	125	μm
Photosensitive area length	7.9872	mm
Package	Glass epoxy	-
Seal material	Silicone resin	-

■ Absolute maximum ratings

Parameter	Symbol	Condition	Value	Unit
Supply voltage	Vdd	Ta=25 °C	-0.3 to +6	V
Gain selection terminal voltage	Vg	Ta=25 °C	-0.3 to +6	V
Clock pulse voltage	V(CLK)	Ta=25 °C	-0.3 to +6	V
Start pulse voltage	V(ST)	Ta=25 °C	-0.3 to +6	V
Operating temperature*1	Topr		-25 to +85	°C
Storage temperature*1	Tstg		-25 to +85	°C
Reflow soldering conditions*2	Tsol		Peak temperature 260 °C, 3 times (See P.7)	-

^{*1:} No condensation

Note: Exceeding the absolute maximum ratings even momentarily may cause a drop in product quality. Always be sure to use the product within the absolute maximum ratings.

^{*2:} JEDEC level 2a

➡ Recommended terminal voltage (Ta=25 °C)

Parameter		Symbol	Min.	Тур.	Max.	Unit
Supply voltage		Vdd	3.3	5	5.25	V
Gain selection High gain		Vg	0	-	0.4	V
terminal voltage	Low gain	vy	Vdd - 0.25	Vdd	Vdd + 0.25	V
Clock pulse voltage	High level	V(CLK)	Vdd - 0.25	Vdd	Vdd + 0.25	V
	Low level		0	-	0.4	V
Start pulse voltage	High level	\//CT\	Vdd - 0.25	Vdd	Vdd + 0.25	V
	Low level	V(ST)	0	-	0.4	V

■ Electrical characteristics [Ta=25 °C, Vdd=5 V, V(CLK)=V(ST)=5 V]

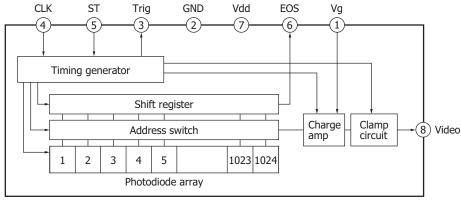
Parameter		Symbol	Min.	Тур.	Max.	Unit
Clock pulse frequency		f(CLK)	100	-	800	kHz
Video data rate		VR	-	f(CLK)/4	-	kHz
Current consumption Vdd=5 V		т	-	5	8	mΛ
Current consumption	Vdd=3.3 V	1	-	4.5	7	- mA

■ Electrical and optical characteristics [Ta=25 °C, f(CLK)=800 kHz, Vdd=5 V: V(CLK)=V(ST)=5 V, Vdd=3.3 V: V(CLK)=V(ST)=3.3 V]

	Parameter	•	Symbol	Min.	Тур.	Max.	Unit
Spectral response range		λ	400 to 1000			nm	
Peak sensitiv	ity waveleng	jth	λр	- 700		-	nm
	Vdd=5 V	High gain		-	0.8	8	
Dark output	vuu=5 v	Low gain	Vd	-	0.4	4	mV
voltage*3 Vdd=3.3 V	High gain	vu	-	0.5	5	IIIV	
	Low gain		-	0.25	2.5		
Saturation output Vd		Vdd=5 V	- Vsat -	2.6	3.2	-	V
voltage	Vdd=3.3 V	1.4		2.0	-	V	
Dandard main		High gain	NI.	-	1.4	2.2	m)/ mm.c
Readout noise	Low gain	Nr	-	0.7	1.1	mV rms	
Output offset voltage		Vo	0.2	0.4	0.6	V	
Photoresponse nonuniformity*4 *5		PRNU	-	-	±8.5	%	

^{*3:} Integration time=10 ms

Block diagram



KMPDC0165ED



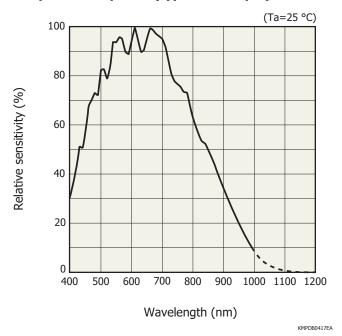
^{*4:} Photoresponse nonuniformity (PRNU) is the output nonuniformity that occurs when the entire photosensitive area is uniformly illuminated by light which is 50% of the saturation exposure level. PRNU is measured using 1022 pixels excluding the pixels at both ends, and is defined as follows:

PRNU= $\Delta X/X \times 100$ (%)

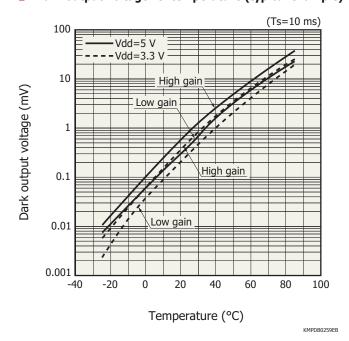
X: average output of 1022 pixels excluding the pixels at both ends, ΔX : difference between X and maximum or minimum output

^{*5:} Measured with a tungsten lamp of 2856 K

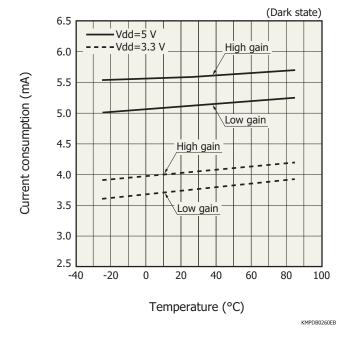
Spectral response (typical example)



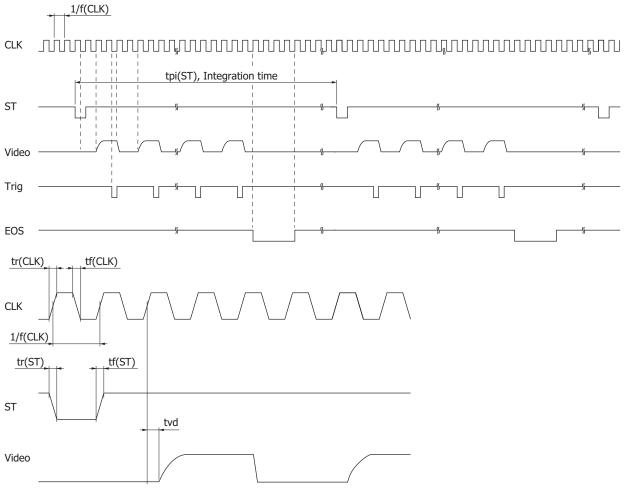
□ Dark output voltage vs. temperature (typical example)



Current consumption vs. temperature (typical example)



- Timing chart



KMPDB0164EC

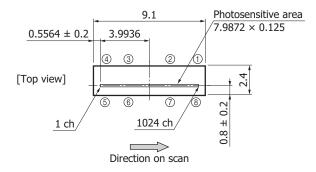
Parameter	Symbol	Min.	Тур.	Max.	Unit
Start pulse interval	tpi(ST)	4104/f(CLK)	-	-	S
Start pulse rise and fall times	tr(ST), tf(ST)	0	20	30	ns
Clock pulse duty ratio	-	40	50	60	%
Clock pulse rise and fall times	tr(CLK), tf(CLK)	0	20	30	ns
Video delay time*6	tvd	10	20	30	ns

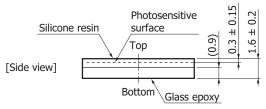
^{*6:} Ta=25 °C, Vdd=5 V, V(CLK)=V(ST)=5 V

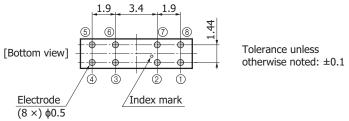
Note: The CLK pulse should be set from high to low just once when the ST pulse is low. The internal shift register starts operating at this timing.

The storage time is determined by the start pulse intervals. However, since the charge storage of each pixel is carried out between the signal readout of that pixel and the next signal readout of the same pixel, the start time of charge storage differs depending on each pixel. In addition, the next start pulse cannot be input until signal readout from all pixels is completed.

Dimensional outline (unit: mm)





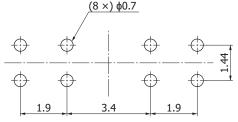


KMPDA0315EB

- Pin connections

Pin no.	Name	I/O	Description		
1	Vg	I	Gain selection; low gain: Vdd or open, high gain: GND		
2	GND	-	Ground		
3	Trig	0	Trigger: timing signal output for A/D converter		
4	CLK	т	Clock pulse (pulse for synchronizing the internally generated pulses that control sensor operation		
	CLK	1	frequency)		
5	ST	т	Start pulse (pulse for initializing the internally generated pulses that set the timing to start		
	51	1	reading pixel signals)		
6	EOS	0	End of scan (shift register end-of-scan signal pulse generated after reading signals from all pixels)		
7	Vdd	I	Power supply voltage		
8	Video	0	Video signal output		

- Recommended land pattern (unit: mm)



KMPDC0248EB

→ Appearance inspection standards

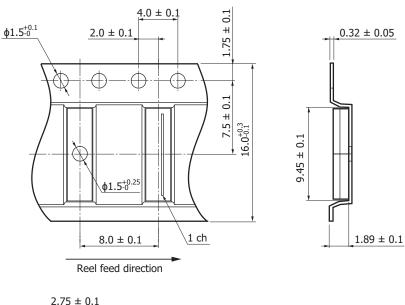
Parameter	Test criterion	Inspection method	
Foreign matter on photosensitive area	10 μm max.	Automated camera	

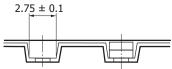
> Standard packing specifications

■ Reel (conforms to JEITA ET-7200)

Dimensions	Hub diameter	Tape width	Material	Electrostatic characteristic
330 mm	100 mm	16 mm	PPE	Conductive

■ Embossed tape (unit: mm, material: polycarbonete resin, conductive)

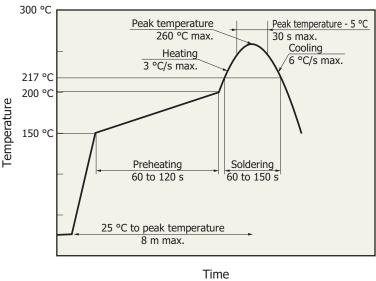




KMPDC0433EA

- Packing quantity 2000 pcs/reel
- Packing type
 Reel and desiccant in moisture-proof packing (vaccum-sealed)

- Recommended temperature profile for reflow soldering (typical example)



KMPDB0405EA

- This product supports lead-free soldering. After unpacking, store it in an environment at a temperature of 30 °C or less and a humidity of 60% or less, and perform soldering within 4 weeks.
- The effect that the product receives during reflow soldering varies depending on the circuit board and reflow oven that are used. Before actual reflow soldering, check for any problems by tesitng out the reflow soldering methods in advance.
- · When three or more months have passed or if the packing bag has not been stored in an environment described above, perform baking. For the baking method, see the related information "Resin sealed type CMOS linear image sensor / Precautions."

Precautions

(1) Electrostatic countermeasures

- This device has a built-in protection circuit as a safeguard against static electrical charges. However, to prevent destroying the device with electrostatic charges, take countermeasures such as grounding yourself, the workbench and tools.
- · Protect this device from surge voltages which might be caused by peripheral equipment.

(2) Package handling

- The photosensitive area of this device is sealed and protected by transparent resin. When compared to a glass faceplate, the surface of transparent resin may be less uniform and is more likely to be scratched. Be very careful when handling this device and also when designing the optical systems.
- · Dust or grime on the light input window might cause nonuniform sensitivity. To remove dust or grime, blow it off with compressed air.

(3) Surface protective tape

• Protective tape is affixed to the surface of this product to protect the photosensitive area. After assembling the product, remove the tape before use.

(4) Operating and storage environments

· Handle the device within the temperature range specified in the absolute maximum ratings. Operating or storing the device at an excessively high temperature and humidity may cause variations in performance characteristics and must be avoided.

(5) UV exposure

· This product is not designed to prevent deterioration of characteristics caused by UV exposure, so do not expose it to UV light.



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S10226-10

Related information

www.hamamatsu.com/sp/ssd/doc_en.html

- Precautions
- · Notice
- · Image sensor / Precautions
- · Resin-sealed CMOS linear image sensors / Precautions

Information described in this material is current as of July, 2014.

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